Index of Claims 10523070 Examiner SHENG HAN Applicant(s)/Patent Under Reexamination YAGI ET AL. Art Unit 1793

✓	Rejected	-	Cancelled	N	Non-Elected	Α	Appeal
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	12	N	-							
	13	N	-							
	14	N	-							
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	18	✓	=							
	19	N	=							
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	21	N	=							
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	29	N	-							
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	31	✓	=							
	32	✓	=							
	33	√	=							
	34	√	=							
	35	✓	=							

	Application/Control No.	Applicant(s)/Patent Under Reexamination
Index of Claims	10523070	YAGI ET AL.
	Examiner	Art Unit
	SHENG HAN	1793

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	48	N	-								
	49	N	-								
	50	N	-								
	51	N	-								
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